



CERN Accelerator School – FELs and ERLs

Case Study: Case 1 / Group 2

Goal: Design a high repetition FEL at a wavelength of 13.5 nm with an average power of more than 2 kW

Case Study Group 2

Group 2		
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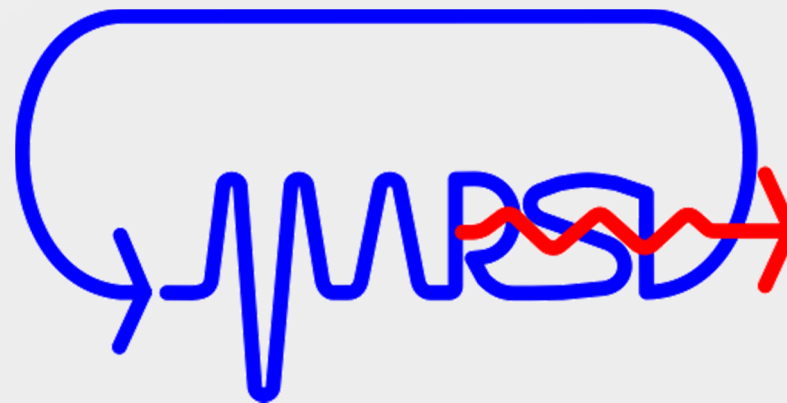
Introduction

1. Background: To generate the fine structures in micro chips with lithography it requires a coherent light source and a mask for the fabrication of wafers. More average power results in faster fabrication. It should be at least above 1 kW because otherwise alternative solution exists.
2. The VUV FEL at a wavelength of 13.5 nm with an average power of more than 2 kW requires around 1 MW of average CW electron beam power ($\rho_{\text{FEL}} \sim 0.2\%$).
3. Because of high required average electron beam power and CW operation an ERL based FEL with superconducting LINAC is proposed to reduce the dumped beam energy to an acceptable level.
4. The FEL undulator is chosen to be planar type variable (20 mm) gap and 30 mm period, close by design to LCLS and FLASH/E-XFEL ones.
5. The ERL design is mainly based on bERLinPro and JAEA projects.

The Name

Multi-kW Advanced EUV Radiation Source
project

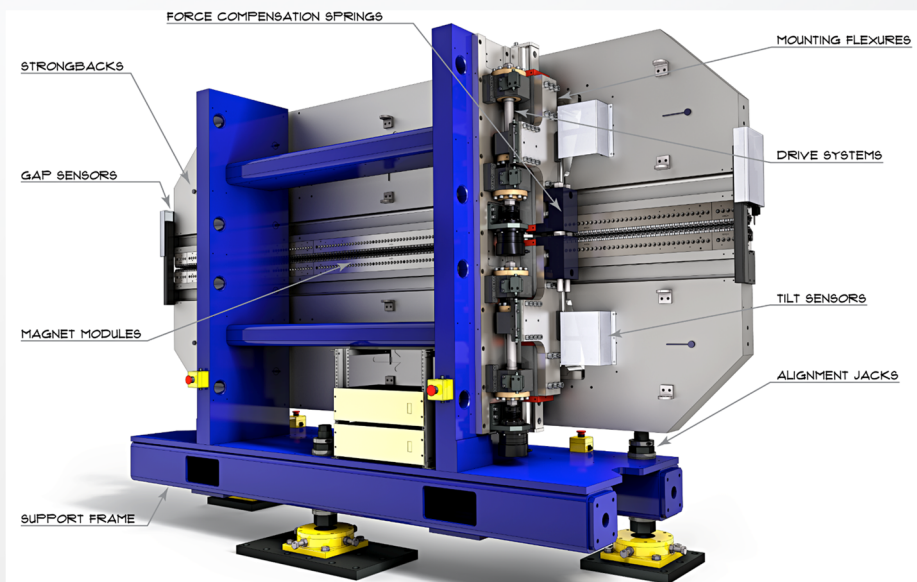
“MARS”



FEL Parameters

Power gain model used:	<input type="text" value="Xie"/>	Input data set:	<input type="text" value="FLASH1"/>
Beam parameters:			
Beam Energy [GeV] :	<input type="text" value="0.60"/>	Norm. Emittance [mm mrad]:	<input type="text" value="1.0"/>
Bunch charge [nC] :	<input type="text" value="0.2"/>	Peak Current [kA] :	<input type="text" value="2"/>
Beam size [μ m] :	<input type="text" value="50.413"/>	bunch length [μ m] :	<input type="text" value="11.968"/>
Undulator parameters:	Type : <input type="text" value="Hybrid with NdFeB"/>	Geometry :	<input type="text" value="planar"/>
Period [mm] :	<input type="text" value="30"/>	K-rms parameter :	<input type="text" value="0.487"/>
Peak field [T] :	<input type="text" value="0.246"/>	Gap [mm] :	<input type="text" value="20.059"/>
FODO period [m] :	<input type="text" value="1"/>	Quadrupole gradient [T/m] :	<input type="text" value="10"/>
Quadrupole focal length [m] :	<input type="text" value="1.332"/>	Average beta-function [m] :	<input type="text" value="2.979"/>
Radiation parameters:			
Radiation wavelength [nm] :	<input type="text" value="13.507"/>	Photon Energy [eV] :	<input type="text" value="91.825"/>
<input type="button" value="finalize"/>			
1D rho parameter (Bonifacio) :	<input type="text" value="0.002598"/>	1D gain length [m] :	<input type="text" value="0.53"/>
3D rho parameter :	<input type="text" value="0.002042"/>	3D gain length [m] :	<input type="text" value="0.675"/>
Shotnoise power [W]:	<input type="text" value="34.935"/>	Saturation power [GW] :	<input type="text" value="3.082"/>
Electrons per wavelength:	<input type="text" value="562792"/>	Effective Energy spread :	<input type="text" value="0.021"/>
Spotsize at exit (FWHM) [μ m] :	<input type="text" value="118.71"/>	Divergence (FWHM) [mrad]:	<input type="text" value="50.21"/>
Pulse duration (FWHM) [fs] :	<input type="text" value="47"/>	Photons per Pulse :	<input type="text" value="0.105E14"/>
Peak Flux [#/sec] :	<input type="text" value="2.098E26"/>	Peak Brilliance* :	<input type="text" value="4.6E30"/>
Average Flux [#/sec] :	<input type="text" value="0.493E18"/>	Average Brilliance* :	<input type="text" value="10.81E21"/>
SR Energy loss [MeV] :	<input type="text" value="0.0002"/>	SR Energy spread [MeV] :	<input type="text" value="0"/>
			3 × 5 m long undulators
			Saturation length [m] : 13.83
			Power at undulator exit [GW] : 3.071
			Diffraction parameter : 4.1
			Bandwidth (FWHM) [%] : 0.48
			Autocorrelation time [fs] : 6.22
			Pulse Energy [mJ] : 0.154

Undulator Parameters



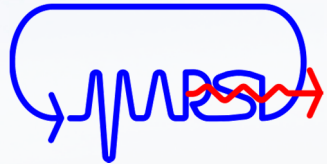
LCLS-II type undulator

D. Arbelaez, LBNL

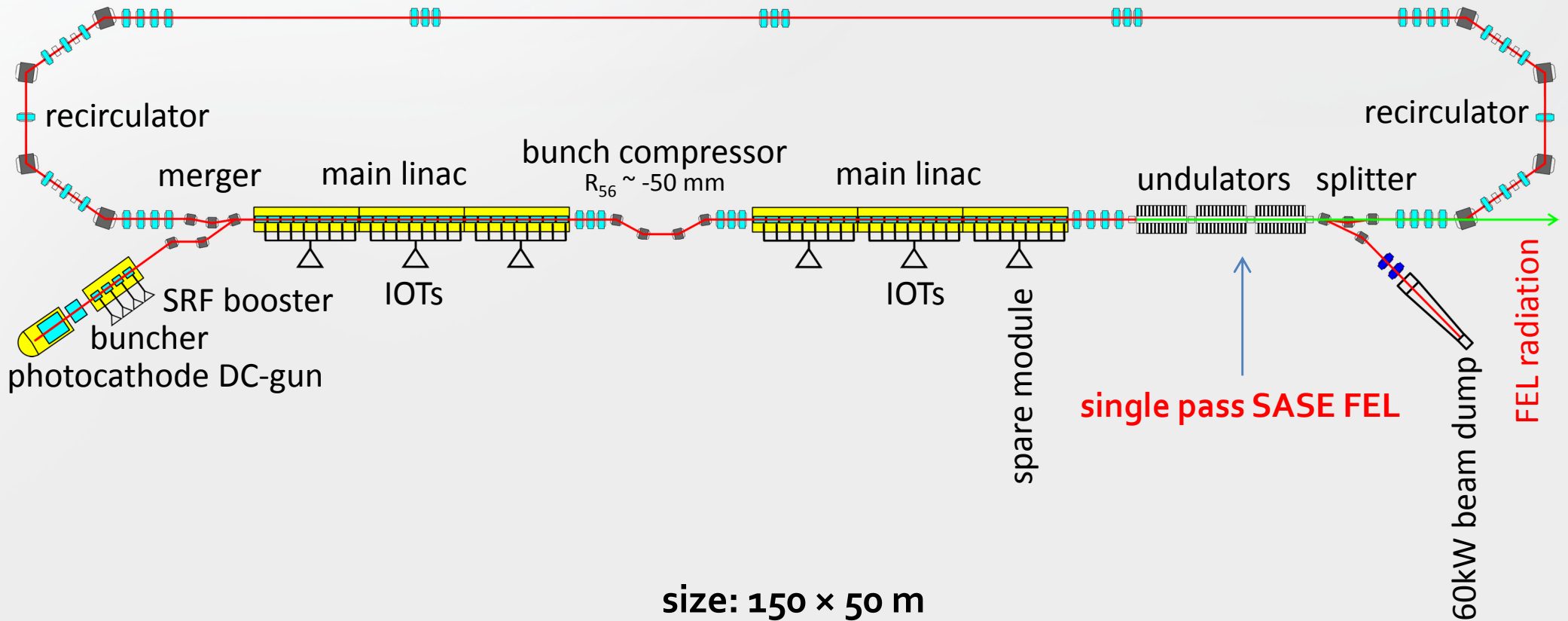
parameter	value
geometry	planar
type	hybrid / variable gap
permanent magnets type	NdFeB / SmCo optional*
period [mm]	30
gap [mm]	20
peak magnetic field [T]	0.246
K-rms parameter	0.487
ρ parameter (3D)	0.002
saturation length [m]	13.8
length [m]	$3 \times 5 = 15$
beam energy [MeV]	600
radiation wavelength [nm]	13.5
average FEL radiation power [kW]	1 .. 12

*to consider for increased life time with the radiation expose.

ERL based FEL Layout

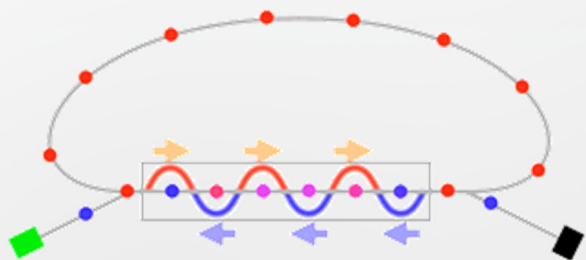


600 MeV energy recovery loop



size: 150 × 50 m

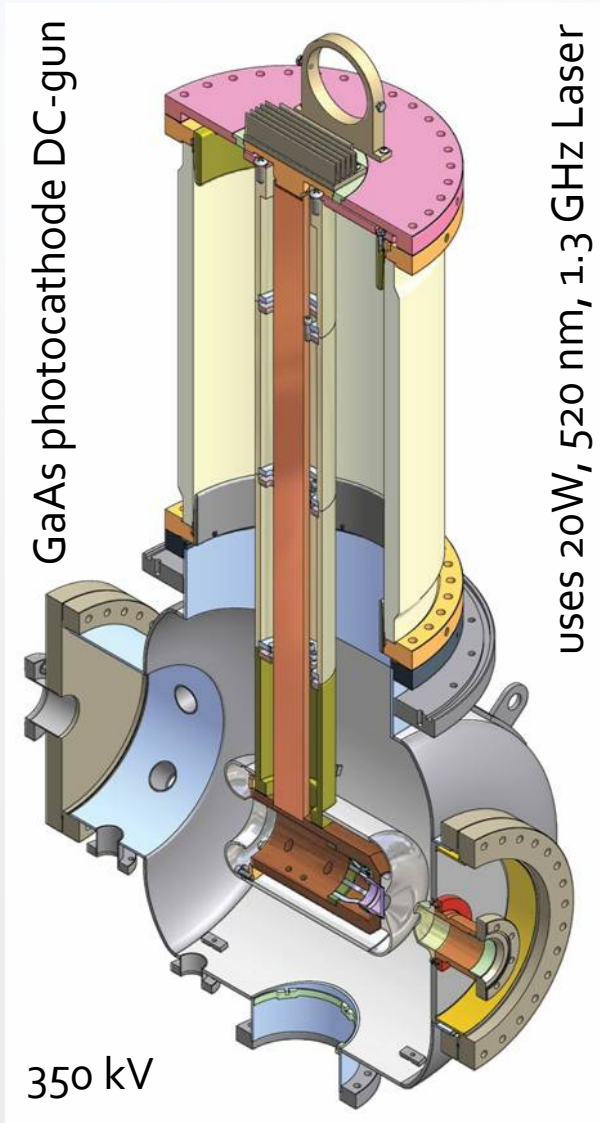
ERL Parameters



single pass recirculation layout

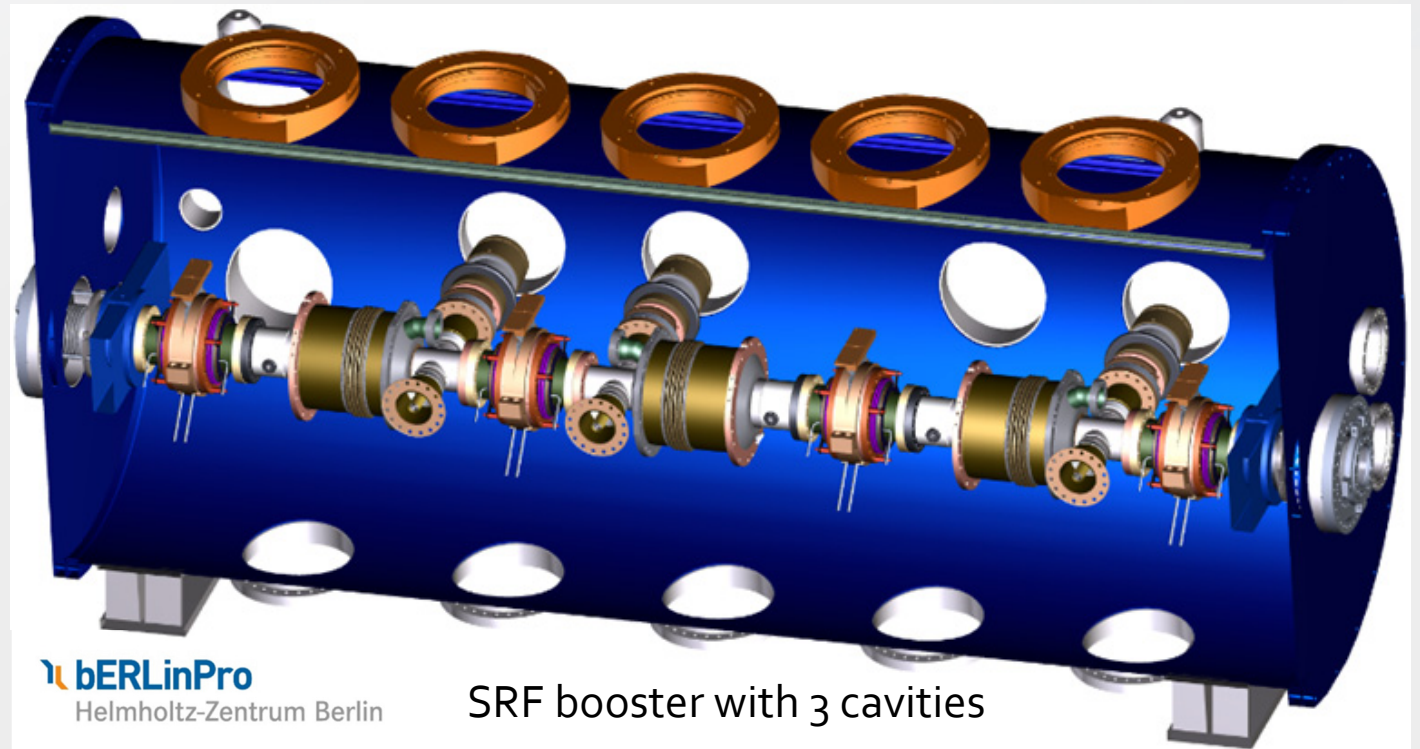
parameter	value
beam energy [MeV]	600
beam current [mA]	1 .. 10
bunch charge [pC]	20 .. 200
beam average power [MW]	0.6 .. 6.0
repetition rate [MHz]	50
normalized emittance [$\mu\text{m}\cdot\text{rad}$]	1.0
bunch transversal size at undulator [μm]	50
bunch length at undulator [μm]	12
DC-gun energy [MeV]	0.35
booster energy [MeV]	6.0
main linac energy [MeV]	600
SRF module energy [MeV]	120
SRF modules number	5 + 1 spare
IOT RF power [kW]	80
converted FEL radiation [kW]	1 .. 12

ERL Injector



CW operation needs a DC-gun, as a proven technology.
Needed parameters reached at Cornell and KEK.

Cornell / bERLinPro SRF booster 4 x 2cell SRF cavities 6MeV



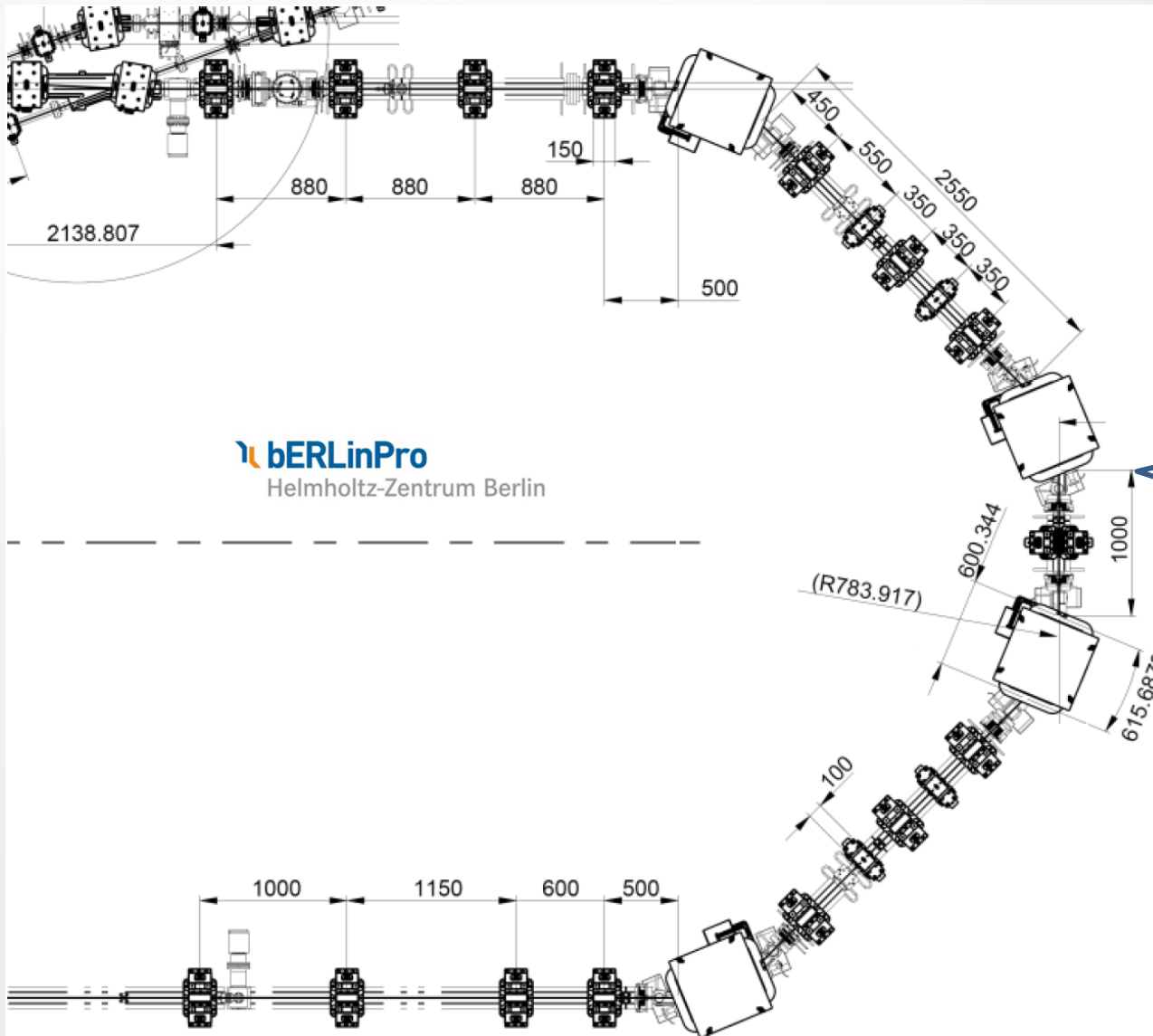
ERL main linac

- accelerating module: 8 cavities / 120 MeV
- main LINAC: 5 (+ 1 spare) modules / 600 MeV
- accelerating cavity: bERLinPro type 7-cell
- RF power source: 80 kW IOT per module
- cryogenics: 1 kW at 1.8 K (LHe)
- LINAC length: $6 \times 10 = 60$ m

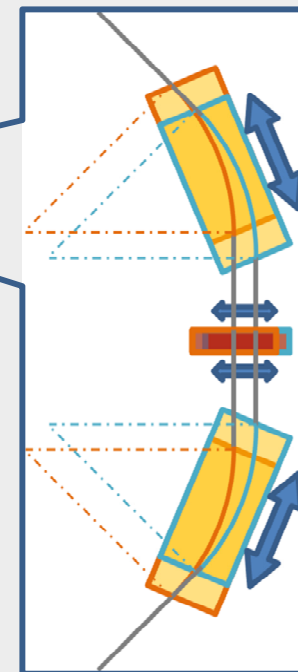


7-cell SRF cavity 20 MV/m, 17 MeV, operating temperature: 1.8 K
strong HOM damping design to cope with a BBU effect.

ERL Recirculator Arcs



Layout from bERLinPro Project:
bend-achromat / adjustable

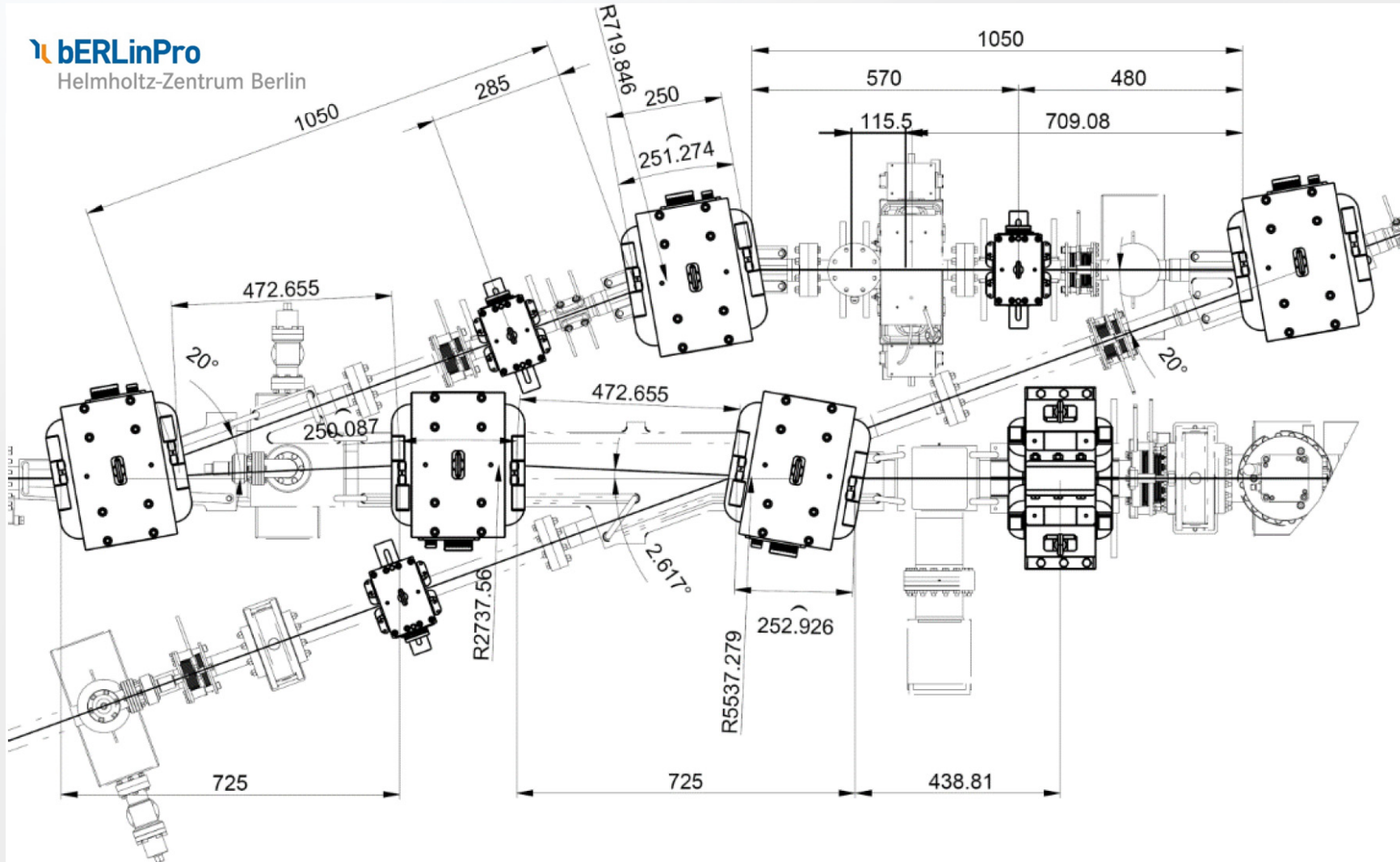


arc beam path adjustment

$$L_{\text{recirculator}} = (n + \frac{1}{2}) \cdot c / f_{\text{RF}}$$

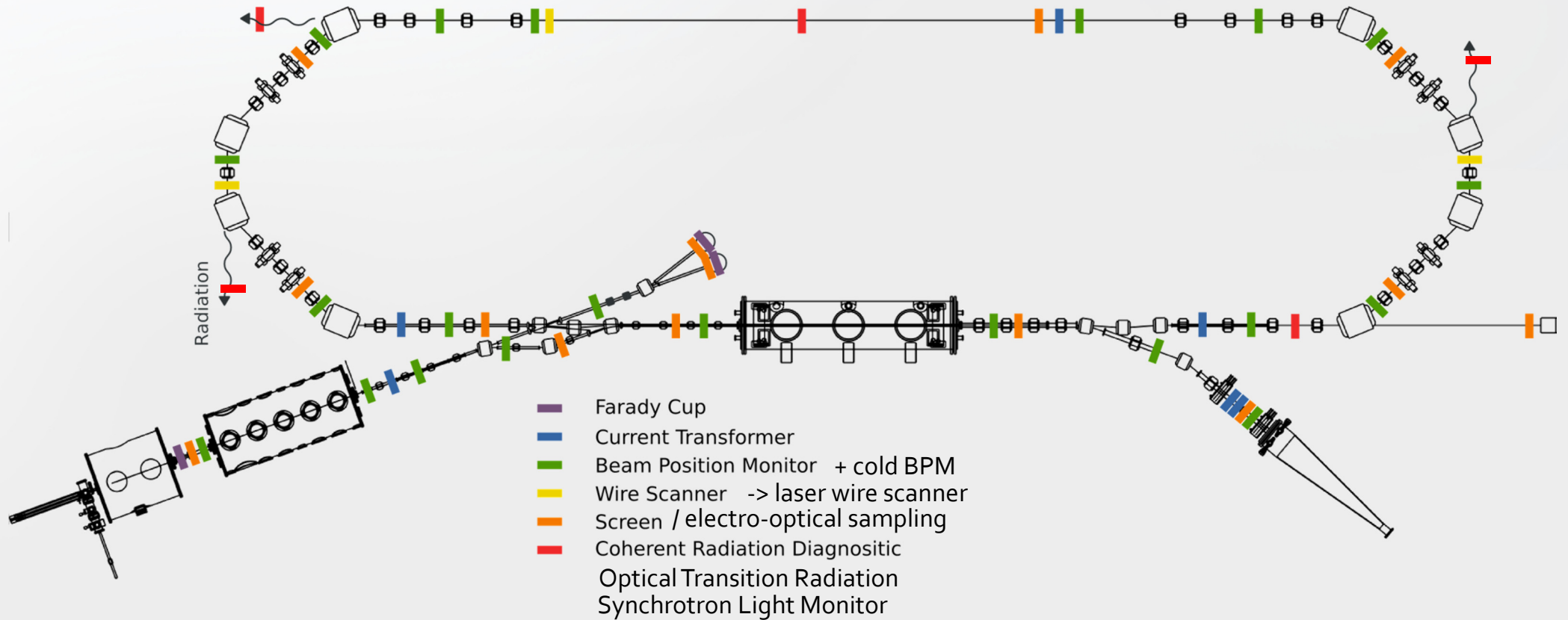
ERL Merger

Layout from bERLinPro Project: dog-leg type, needs 6 / 600 MeV merging

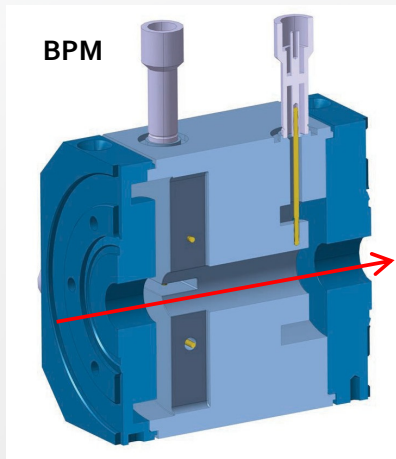
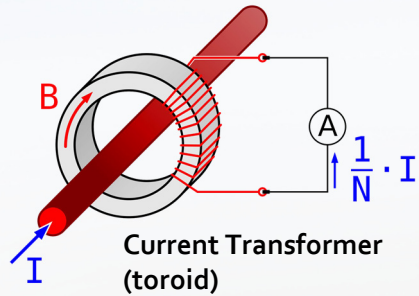


ERL Diagnostics

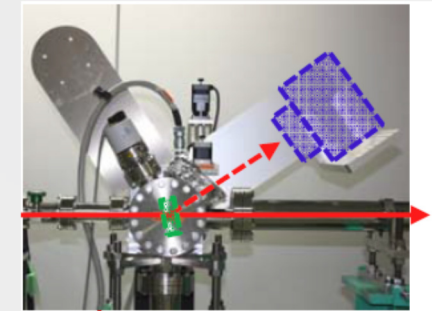
Layout from bERLinPro Project



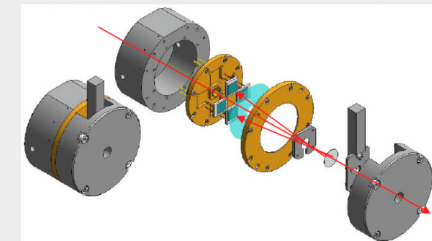
FEL-ERL Diagnostics Summary



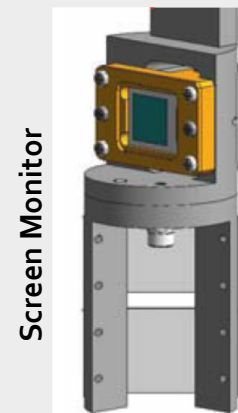
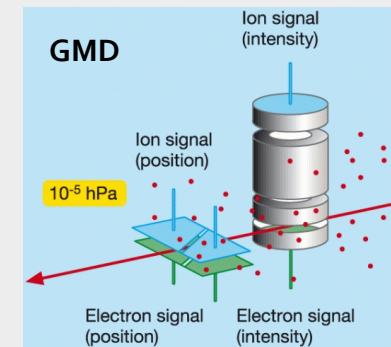
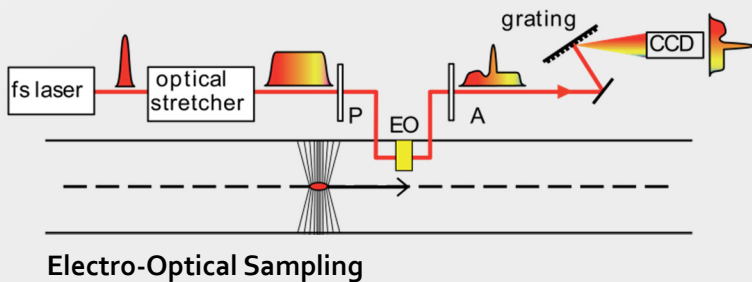
electron beam	photon beam
Farady Cup	Wave Length Monitor
Current Transformer	Pulse Energy Monitor
Beam Position Monitor	Screen Monitor
Laser Wire Scanner	Gas Monitor Detector
Screen	
Electro-Optical Sampling	
Optical Transition Radiation	
Synchrotron Light Monitor	
Beam Arrival Monitor	



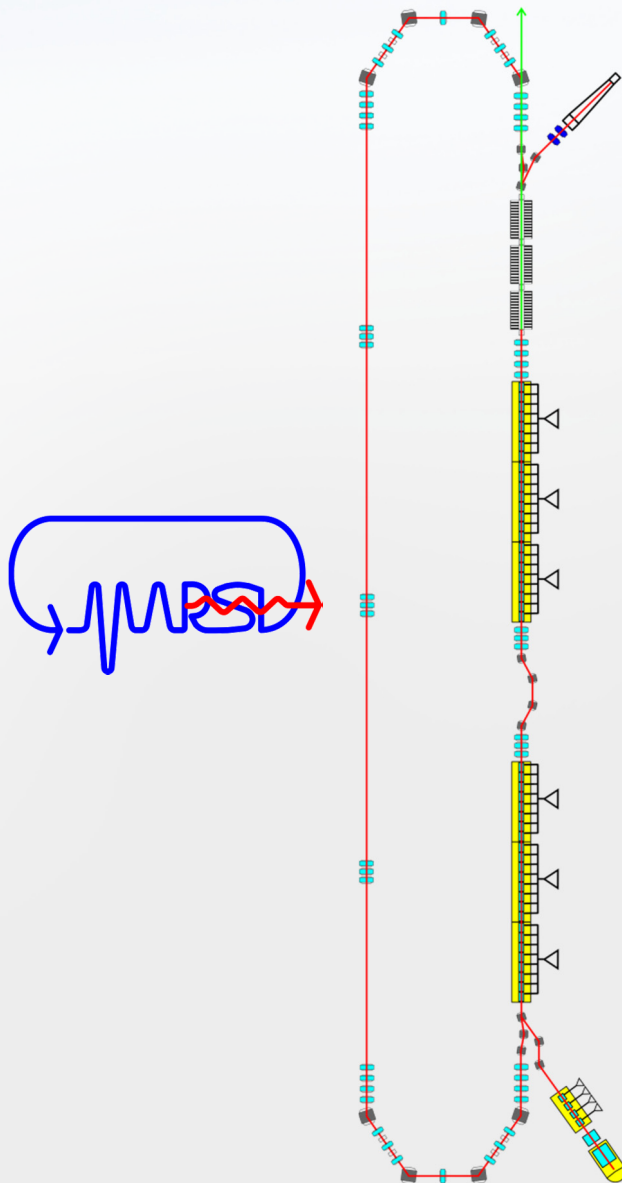
Wave Length Monitor



Pulse Energy Monitor



Cost Estimation



position	cost [M€]
Building 150×50×15 m ³	20
shielding iron/concrete 10 ⁴ t	1.2
air conditioning facility	1.0
water cooling facility	1.0
primary & indoor substation facility	1.3
He gas refrigerator facility 1.8 K 1 kW	14
SRF accelerator module	1.0
Undulators	1.5
accelerator facility 10 mA 600 MeV	30
EUV FEL facility (EUVL)	5
Total Construction Cost	76
Operation Cost (1 year)	
electricity 0.25€/kWh	6

Summary

1. Extreme ultraviolet lithography (also known as EUV or EUVL) is a next-generation lithography technology using an extreme ultraviolet (EUV) wavelength, currently expected to be 13.5 nm.
2. 13.5 nm 10 kW average power range 600 MeV 10 mA ERL based high repetition FEL EUV radiation source "**MARS**" is proposed.
3. Proposed facility design is mainly based on proved and already available and tested solutions with accent on the reliability.
4. Facility upgrade options may include the energy upgrade up to 750 MeV using the spare SRF accelerating module and up to 1.5 GeV with a possible double-pass ERL layout, which would allow to reach 10 and 1 nm radiation wavelength ranges respectively, with some undulators adjustments or upgrades. An average current upgrade up to 50 .. 100 mA is another option, implemented technology cutting edge is 100 mA and this is being currently tested in several labs.

References

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